United States Patent [19]

Kronish et al.

[11] Des. 252,157

[45] ** Jun. 19, 1979

[54]	DIAGNOSTIC DEVICE FOR MEASURING BIOCHEMICAL CHARACTERISTICS OF MICROORGANISMS AND THE LIKE		
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[**]	Term:	14 Years	
[21]	Appl. No.:	787,658	
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[51]	Int. Cl	D24—02; D9—04	
521	U.S. Cl	D24/17; D24/21;	
(1		D24/31; D9/189	
[58]	Field of Search		
		9, 127; 23/259, 253 R; D24/17, 21, 99,	
		31; D9/187, 189	
[56]		References Cited	
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Primary Examiner—Bernard Ansher Attorney, Agent, or Firm—Albert H. Graddis

[57] CLAIM

An ornamental design for a diagnostic device for measuring biochemical characteristics of microorganisms and the like, substantially as shown and described.

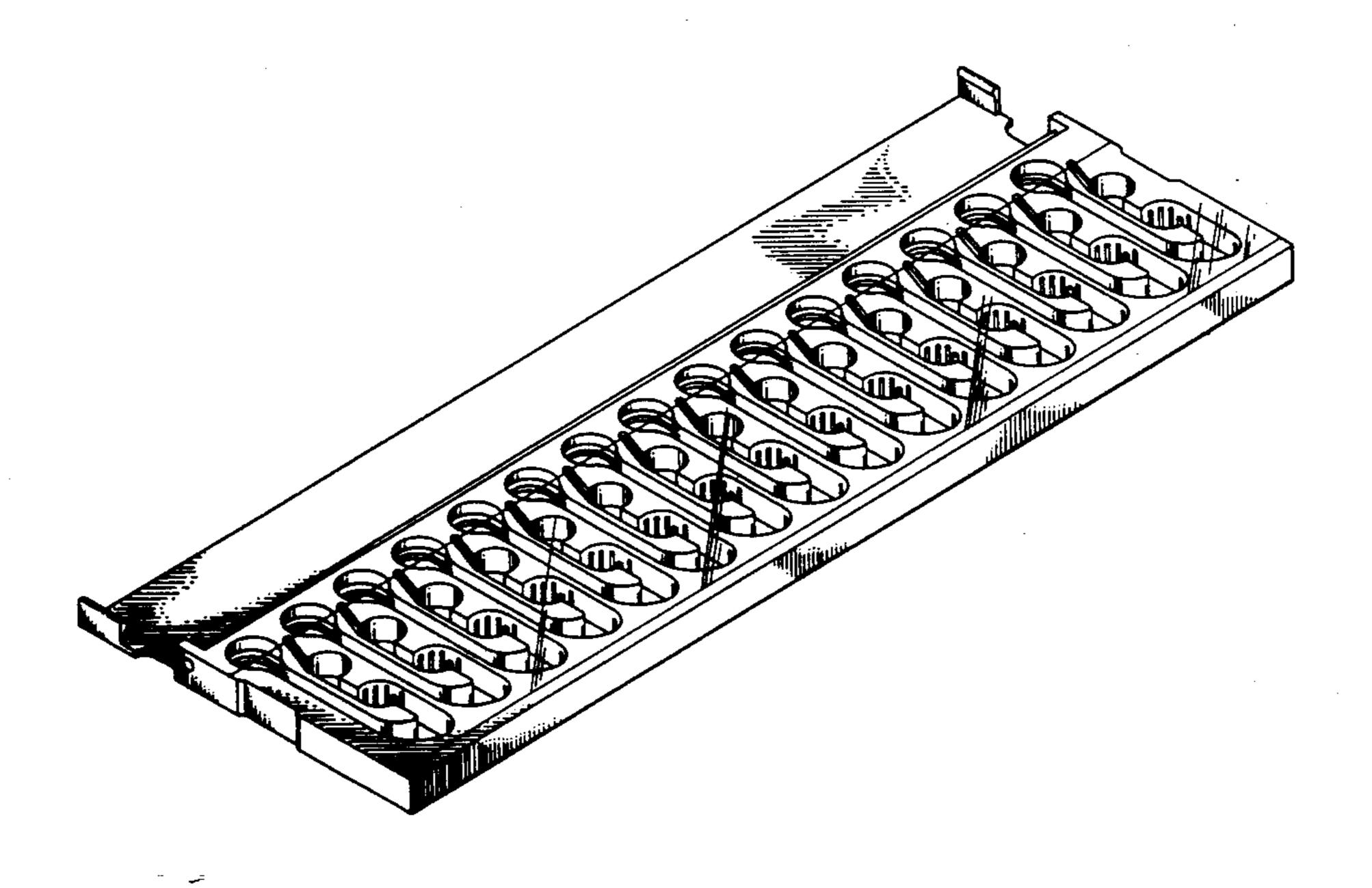
DESCRIPTION

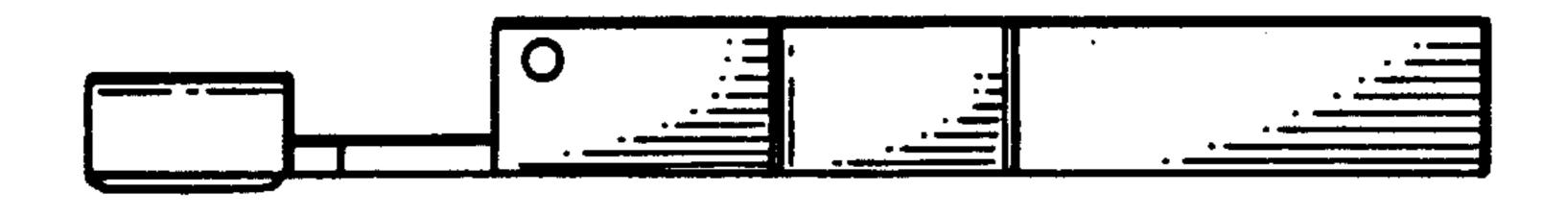
FIG. 1 is a top perspective view of a diagnostic device for measuring biochemical characteristics of microorganisms and the like;

FIG. 2 is a side elevational view of the diagnostic device for measuring biochemical characteristics of microorganisms and the like;

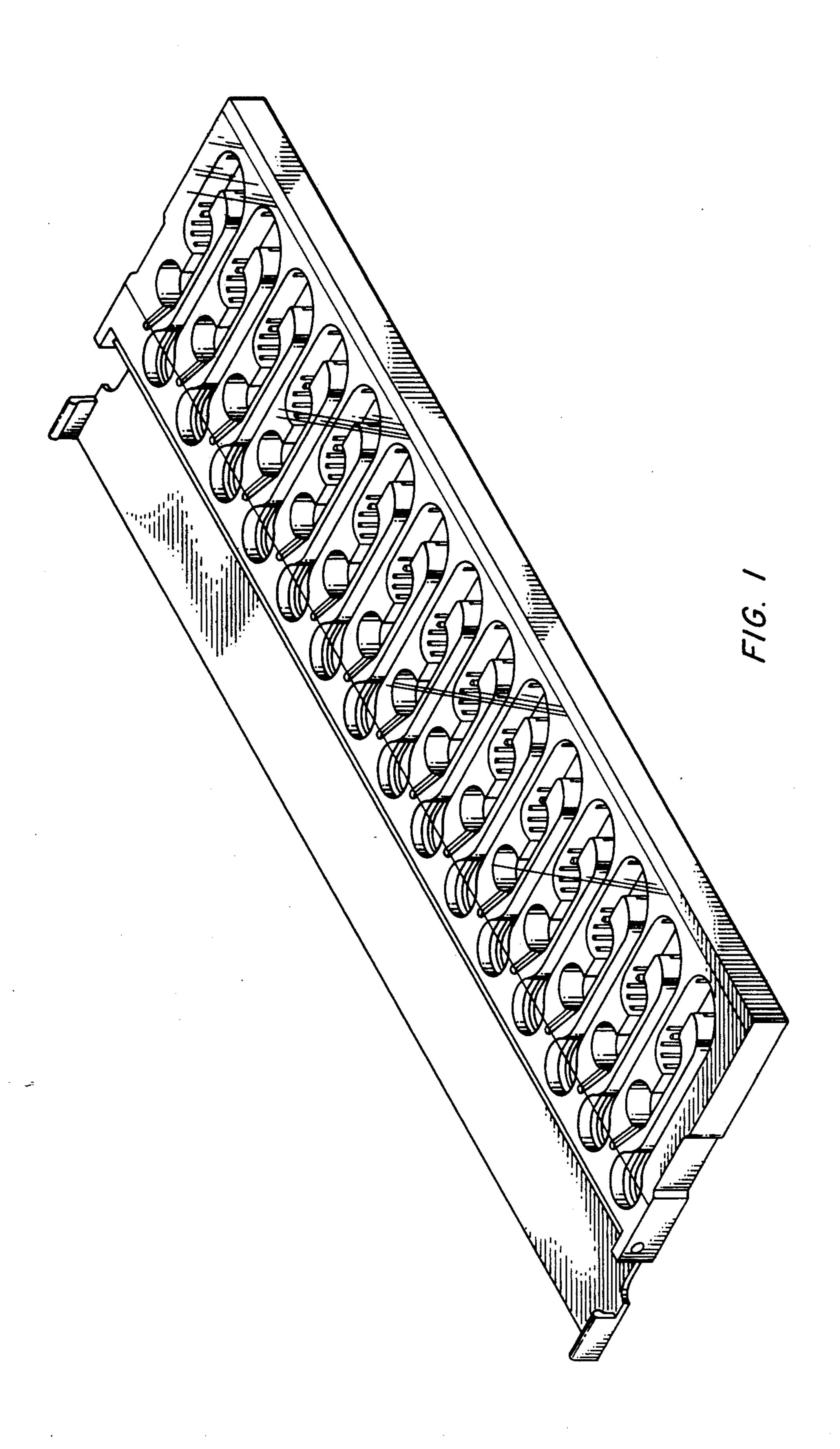
FIG. 3 is a top plan view of the diagnostic device for measuring biochemical characteristics of microorganisms and the like of FIG. 1; and

FIG. 4 is a rear elevational view of the diagnostic device for measuring biochemical characteristics of microorganisms and the like of FIG. 1 with the cover closed.





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